

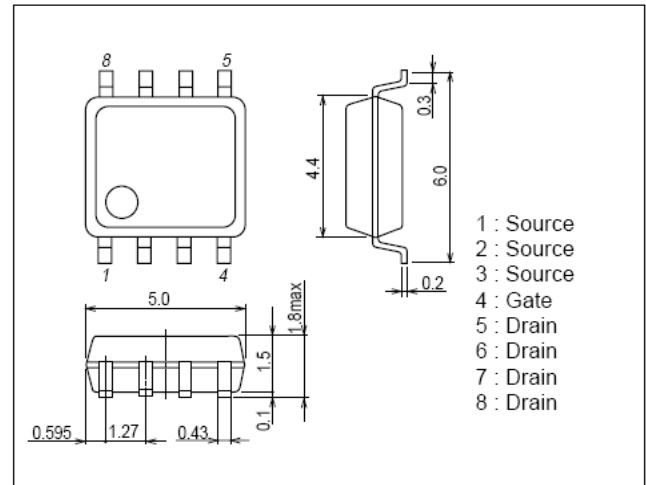
Features

- Low On resistance.
- -4.5V drive.
- RoHS compliant.



Package Dimensions

unit : mm
SOP-8



Specifications

Absolute Maximum Ratings at $T_a=25^{\circ}\text{C}$

Parameter	Symbol	Conditions	Ratings	Unit
Drain-to-Source Voltage	V_{DSS}		-30	V
Gate-to-Source Voltage	V_{GSS}		+25	V
Drain Current (DC)	I_D		-9.2	A
Drain Current (Pulse)	I_{DP}	$PW \leq 10\mu\text{s}$, duty cycle $\leq 1\%$	-60	A
Allowable Power Dissipation	P_D	Mounted on a ceramic board (1000mm ² ×0.8mm) 1unit	1.3	W
Total Dissipation	P_T	Mounted on a ceramic board (1000mm ² ×0.8mm)	1.7	W
Channel Temperature	T_{ch}		150	$^{\circ}\text{C}$
Storage Temperature	T_{stg}		-55~+150	$^{\circ}\text{C}$

Electrical Characteristics at $T_a=25^{\circ}\text{C}$

Parameter	Symbol	Conditions	Ratings			Unit
			min	typ	max	
Drain-to-Source Breakdown Voltage	$V_{(BR)DSS}$	$I_D = -250\mu\text{A}$, $V_{GS} = 0\text{V}$	30			V
Zero-Gate Voltage Drain Current	I_{DSS}	$V_{DS} = -30\text{V}$, $V_{GS} = 0\text{V}$			-10	μA
Gate-to-Source Leakage Current	I_{GSS}	$V_{GS} = \pm 25\text{V}$, $V_{DS} = 0\text{V}$			± 100	nA
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}$, $I_D = -250\mu\text{A}$	-1.7	-2.3	-3.0	V
Forward Transconductance	g_{FS}	$V_{DS} = -5\text{V}$, $I_D = -10\text{A}$		21		S
Static Drain-to-Source On-State Resistance	$R_{DS(ON)}$	$I_D = -12\text{A}$, $V_{GS} = -10\text{V}$		10	13	m Ω
	$R_{DS(ON)}$	$I_D = -10\text{A}$, $V_{GS} = -5\text{V}$		27	38	m Ω
Input Capacitance	C_{iss}	$V_{DS} = -15\text{V}$, $V_{GS} = 0\text{V}$, $f = 1\text{MHz}$		2060	2600	pF
Output Capacitance	C_{oss}	$V_{DS} = -15\text{V}$, $V_{GS} = 0\text{V}$, $f = 1\text{MHz}$		370		pF
Reverse Transfer Capacitance	C_{rss}	$V_{DS} = -15\text{V}$, $V_{GS} = 0\text{V}$, $f = 1\text{MHz}$		295		pF

Electrical Characteristics at $T_a=25^{\circ}\text{C}$ (Continued)

Parameter	Symbol	Conditions	Ratings			Unit
			min	Typ	max	
Turn-on Delay Time	$t_{d(on)}$	$V_{GS}=-10\text{V}, V_{DS}=-15\text{V}, R_L=1.25\Omega,$ $R_{GEN}=3\Omega$		11		nS
Rise Time	t_r			9.4		nS
Turn-off Delay Time	$t_{d(off)}$			24		nS
Fall Time	t_f			12		nS
Total Gate Charge	Q_g	$V_{DS}=-10\text{V}, V_{GS}=-15\text{V}, I_D=-12\text{A}$		30	39	nC
Gate-to-Source Charge	Q_{gs}			4.6		nC
Gate-to-Drain "Miller" Charge	Q_{gd}			10		nC
Diode Forward Voltage	V_{SD}	$I_S=-1\text{A}, V_{GS}=0\text{V}$		-0.7	-1.0	V

Typical Characteristics at $T_a=25^{\circ}\text{C}$

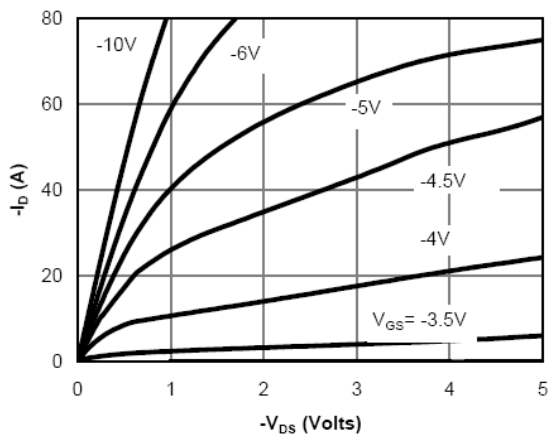


Figure 1: On-Region Characteristics

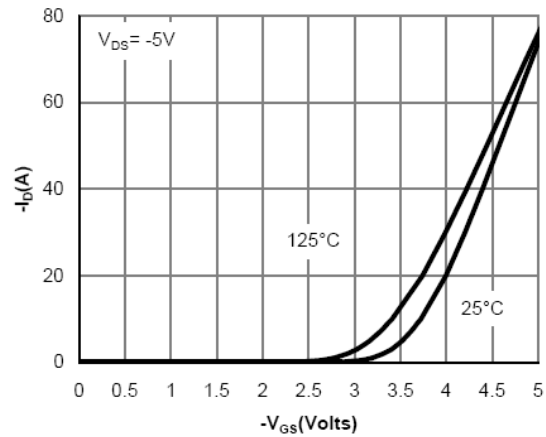


Figure 2: Transfer Characteristics

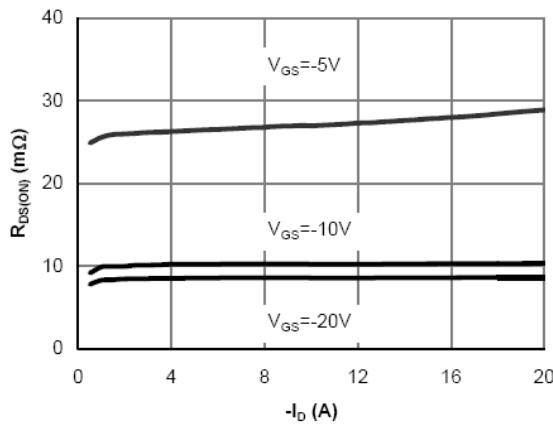


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

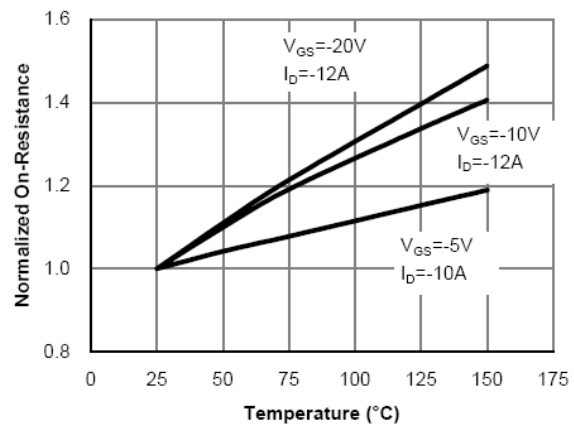


Figure 4: On-Resistance vs. Junction Temperature

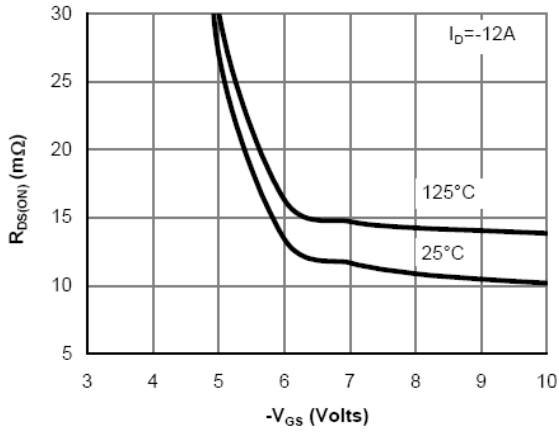


Figure 5: On-Resistance vs. Gate-Source Voltage

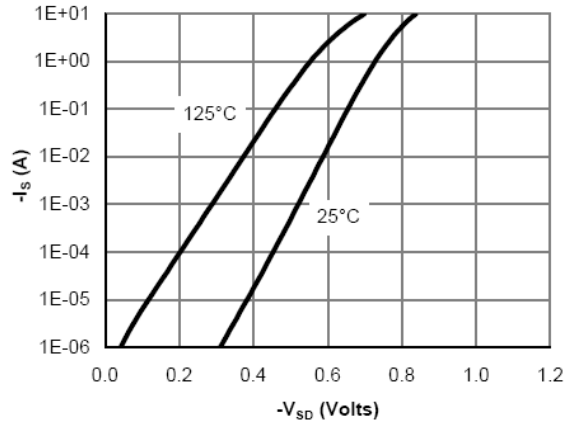


Figure 6: Body-Diode Characteristics

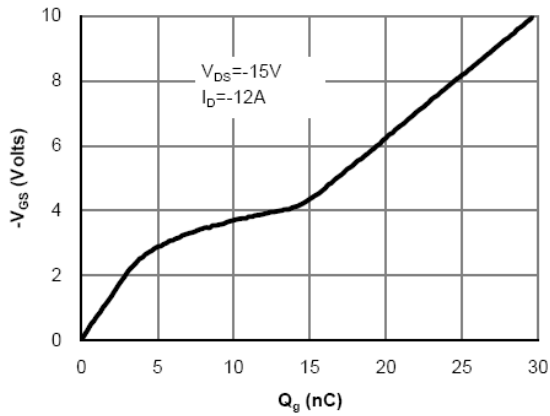


Figure 7: Gate-Charge Characteristics

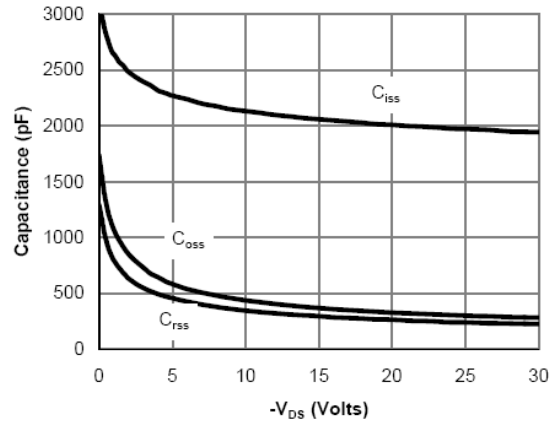


Figure 8: Capacitance Characteristics

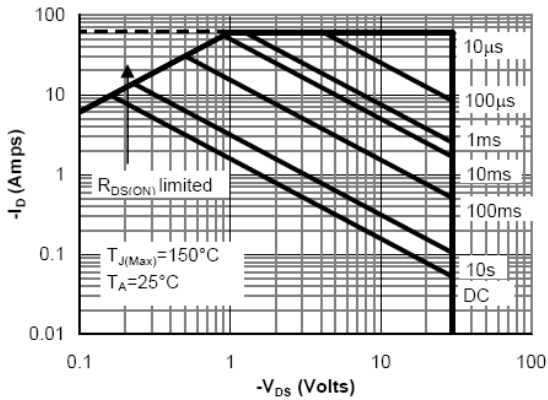


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

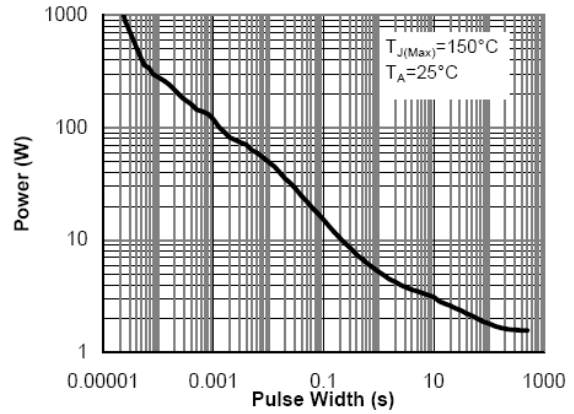


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

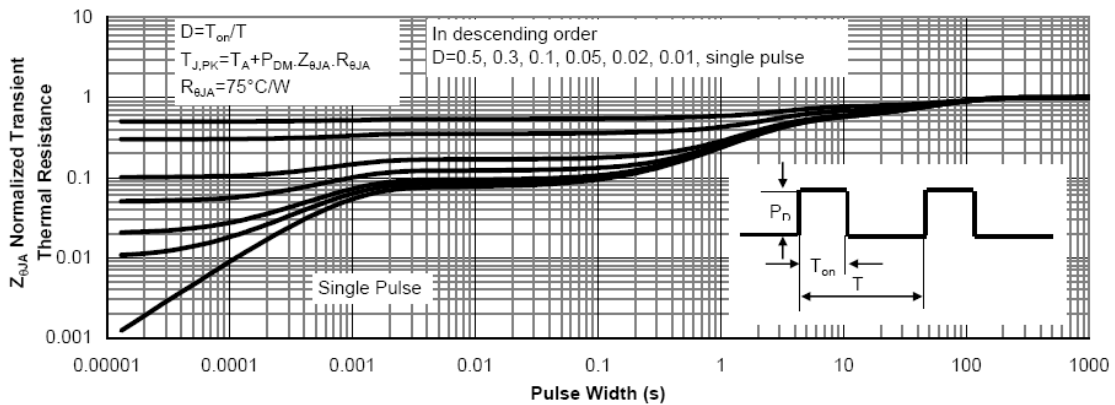


Figure 11: Normalized Maximum Transient Thermal Impedance (Note E)